



DMC3026LSD

Product Summary

Device	V _{(BR)DSS}	R _{DS(ON)} max	l _D max T _A = +25°C
Q1 30V	25mΩ @ V _{GS} = 10V	6.5A	
	300	29mΩ @ V _{GS} = 4.5V	6.1A
Q2	-30V	28mΩ @ V _{GS} = -10V	-6.2A
		38mΩ @ V _{GS} = -4.5V	-5.3A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Backlighting

Features and Benefits

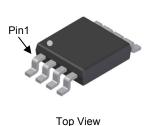
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)

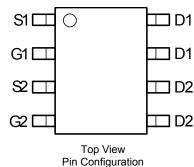
COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

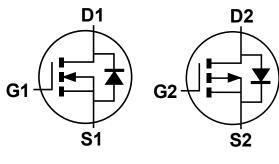
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.074 grams (approximate)







Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3026LSD-13	SO-8	2,500/Tape & Reel

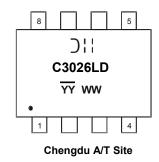
Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

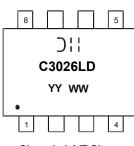
2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information





Shanghai A/T Site



Maximum Ratings – Q1 and Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Q1	Q2	Units		
Drain-Source Voltage	V _{DSS}	30 ±20	-30 ±20	V V		
Gate-Source Voltage	V _{GSS}					
Continuous Drain Current (Note 6) \/ = 10\/	Steady State	T _A = +25°C T _A = +70°C	Ι _D	6.5 5.2	-6.2 -5.0	A
Continuous Drain Current (Note 6) V _{GS} = 10V	t<10s	T _A = +25°C T _A = +70°C	I _D	8.2 6.7	-8.0 -6.5	А
Maximum Body Diode Forward Current (Note 6)	•	ls	2.2	-2.5	A	
Pulsed Drain Current (10µs pulse, duty cycle = 1	I _{DM}	40	-40	А		
Avalanche Current (Notes 7) L = 0.1mH	I _{AS}	14.5	22	А		
Avalanche Energy (Notes 7) L = 0.1mH			E _{AS}	10.5	25	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Tatal Dower Dissinction (Nata 5)	T _A = +25°C	P	1.2	W
Total Power Dissipation (Note 5)	T _A = +70°C	PD	0.8	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	D	102	°C/W
memai resistance, sunction to Amblent (Note 5)	t<10s	$R_{\theta JA}$	62	
Total Power Dissipation (Note 6)	T _A = +25°C	Po	1.6	w
Total Power Dissipation (Note 6)	T _A = +70°C	PD	1.0	
Thermal Registeres, Junction to Ambient (Note 6)	Steady state	De	78	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	R _{0JA}	47	
Thermal Resistance, Junction to Case (Note 6)	Rejc	14.5		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						•
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	_	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1	μA	V _{DS} = 24V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	V _{GS} = ±20V, V _{DS} = 0V
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1	_	3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	P	_	19	25	mΩ	V _{GS} = 10V, I _D = 6A
	R _{DS (ON)}	_	22	29	1115.2	V _{GS} = 4.5V, I _D = 5A
Diode Forward Voltage	V _{SD}	_	0.7	1.2	V	V _{GS} = 0V, I _S = 1.3A
DYNAMIC CHARACTERISTICS (Note 9)					_	
Input Capacitance	C _{iss}	_	641	—		V _{DS} = 15V, V _{GS} = 0V f = 1.0MHz
Output Capacitance	C _{oss}	_	66	—	pF	
Reverse Transfer Capacitance	C _{rss}	_	51	—		
Gate Resistance	R _G	_	2.2	_	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	6	_		
Total Gate Charge (V _{GS} = 10V)	Qg	_	13.2	_	nC	V _{DS} = 15V, I _D = 10A
Gate-Source Charge	Q _{gs}	_	1.7	_	IIC IIC	
Gate-Drain Charge	Q _{gd}	_	2.2	_		
Turn-On Delay Time	t _{D(on)}		3.3			
Turn-On Rise Time	tr		4.4		nS	V_{GS} = 10V, V_{DD} = 15V, R_{G} = 6 Ω ,
Turn-Off Delay Time	t _{D(off)}	_	22.3		113	I _D = 1A
Turn-Off Fall Time	t _f	_	5.3	_	1	

 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
UIS in production with L = 0.1mH, starting T_A = +25°C.
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing. Notes:



Electrical Characteristics – Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Мах	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)				-	_		
Drain-Source Breakdown Voltage	BV _{DSS}	-30	_	—	V	V_{GS} = 0V, I _D = -250µA	
Zero Gate Voltage Drain Current	I _{DSS}		—	-1	μA	V_{DS} = -24V, V_{GS} = 0V	
Gate-Source Leakage	I _{GSS}		—	±100	nA	V_{GS} = ±20V, V_{DS} = 0V	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(th)}	-1	_	-3	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$	
Static Drain-Source On-Resistance	B	_	21	28	mΩ	V_{GS} = -10V, I_{D} = -6A	
	R _{DS(ON)}	_	29	38		V _{GS} = -4.5V, I _D = -5A	
Diode Forward Voltage	V _{SD}	_	-0.7	-1.2	V	V _{GS} = 0V, I _S = -1.3A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}	_	1241	—	pF	V _{DS} = -15V, V _{GS} = 0V f = 1.0MHz	
Output Capacitance	C _{oss}		146	_			
Reverse Transfer Capacitance	C _{rss}	_	110	_			
Gate Resistance	R _G	_	14.8	_	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz	
Total Gate Charge (V_{GS} = -4.5V)	Qg	_	10.9	_			
Total Gate Charge (V _{GS} = -10V)	Qg		22	_	nC	V _{DS} = -15V, I _D = -7A	
Gate-Source Charge	Q _{gs}	_	3.5	_			
Gate-Drain Charge	Q _{gd}	_	4.7	_			
Turn-On Delay Time	t _{D(on)}	_	9.7	_		V _{GS} = -10V, V _{DD} = -15V, R _{GEN} = 6Ω	
Turn-On Rise Time	tr	_	17.1		nS		
Turn-Off Delay Time	t _{D(off)}	_	60.5			I _D = -7A	
Turn-Off Fall Time	t _f	_	40.4	_	1		

 8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to product testing. Notes:



= 85°C

25°C

-55°C

3

T_A = 125°C

 $T_A = 25^{\circ}C$

20

V_{GS} = 4.5V

I_D = 5A

15

50

75

3.5

T_A = 150°C

T_A = 85°C

 $T_A = -55^{\circ}C$

25

V_{GS} = 10V I_D = 10A

125

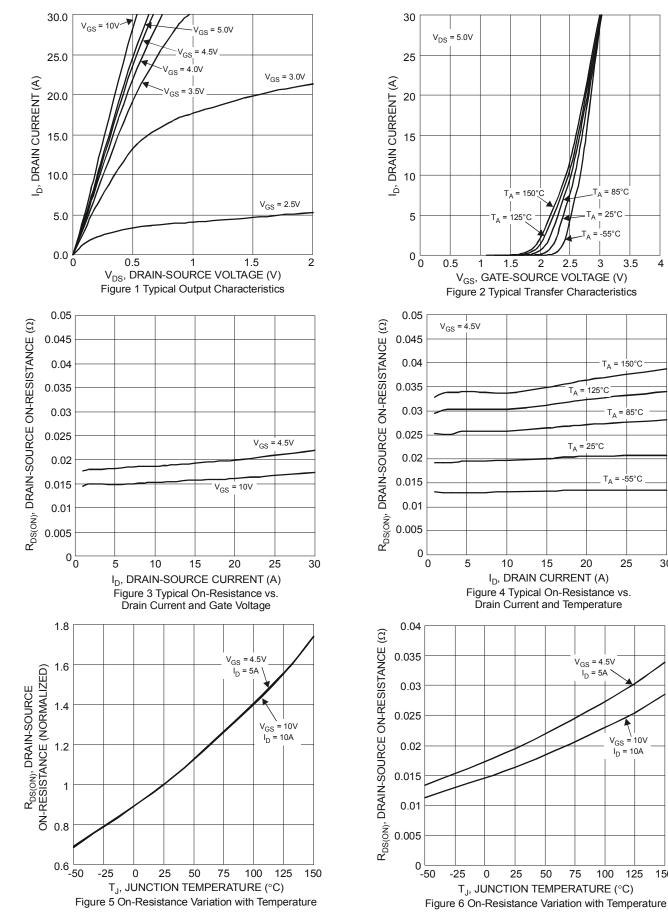
100

30

4

2.5

2

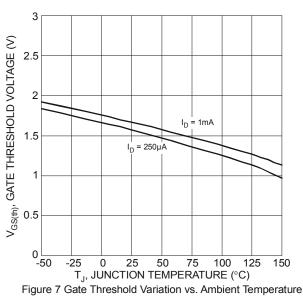


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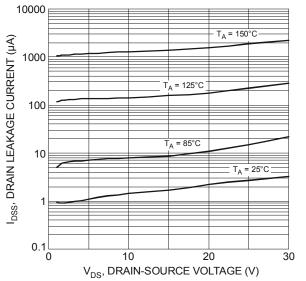
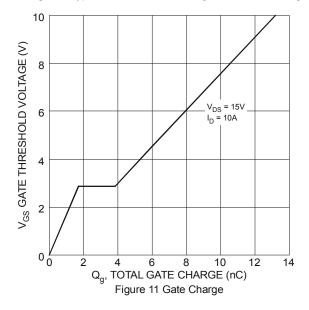
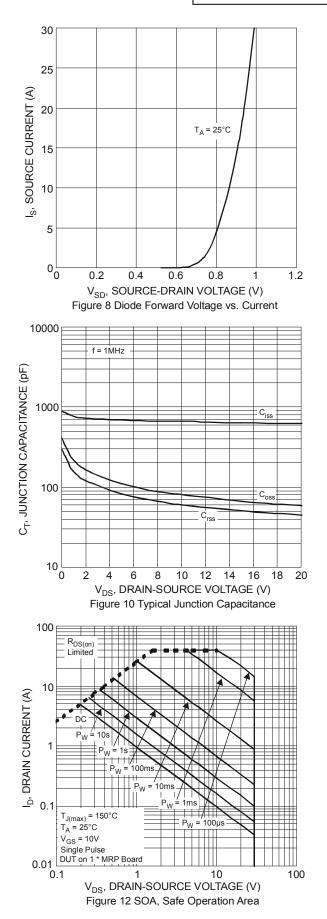


Figure 9 Typical Drain-Source Leakage Current vs. Voltage

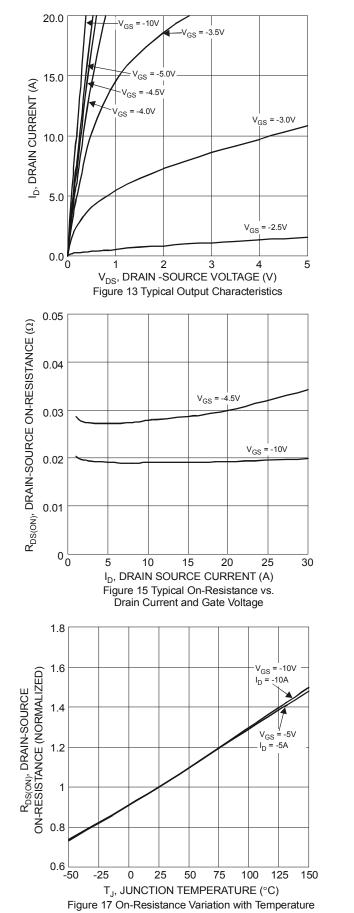


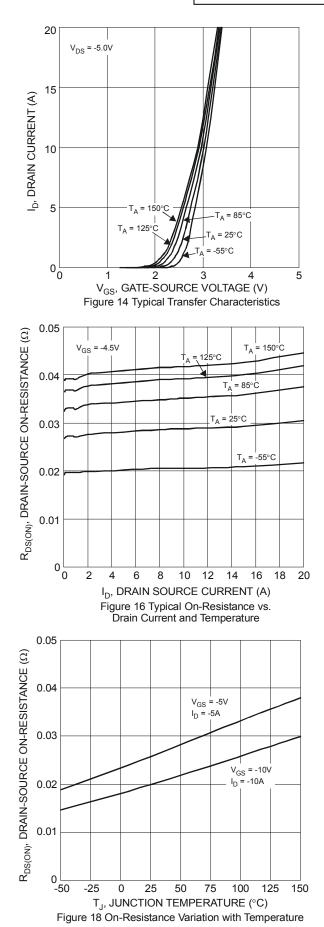


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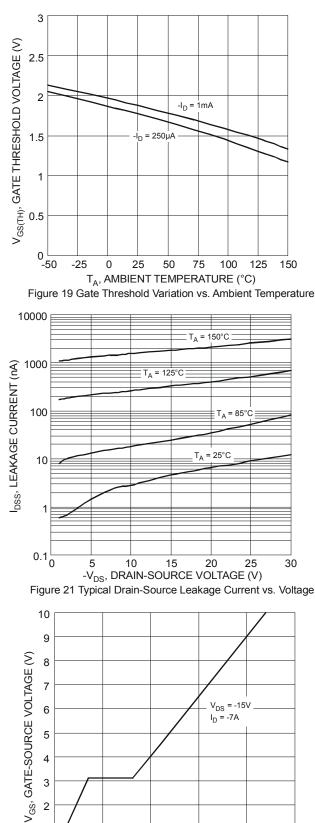


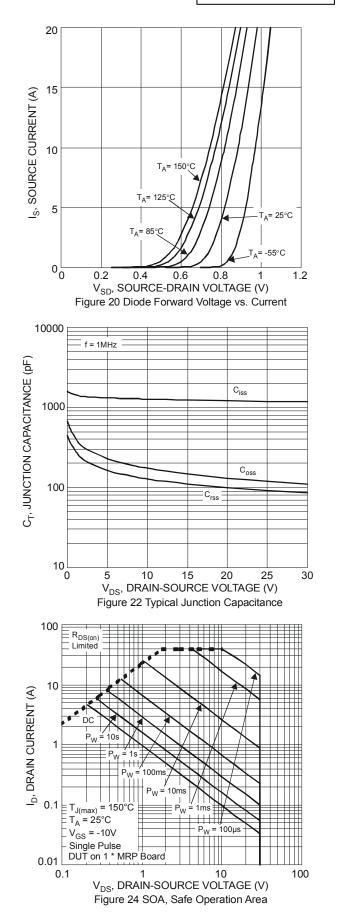
NEW PRODUCT

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DMC3026LSD





NEW PRODUCT

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Q_a, TOTAL GATE CHARGE (nC)

Figure 23 Gate-Charge Characteristics

15

20

25

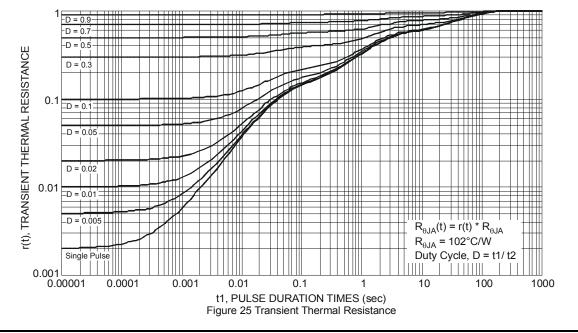
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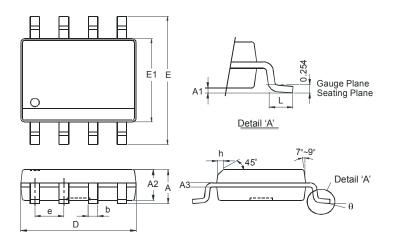
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Package Outline Dimensions

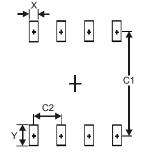
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SO-8						
Dim	Min	Max					
Α	-	1.75					
A1	0.10	0.20					
A2	1.30	1.50					
A3	0.15	0.25					
b	0.3	0.5					
D	4.85	4.95					
Е	5.90	6.10					
E1	3.85	3.95					
e	1.27	Тур					
h	- 0.35						
L	0.62	0.82					
θ	θ 0°						
All Di	All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27



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